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FORM PTO-1449	Atty. Dkt. No.: ARK00797234B	Serial No.: 10/020,776
	Applicant: Fritsch et al.	
	Filing Date:	Group Art:
	12/12/01	
INFORMATION DISCLOSURE STATEMENT BY APPLICANT		

U.S. PATENT DOCUMENTS

Examiner Initial	Document No.	Date	Name	Class	Sub Class	Filing Date If Appropriate
Qn	AA *4,779,031	10/18/88	Arends et al.	318	565	1/15/86
Qn	AB *4,891,242	1/2/90	Ito et al.	427	53.1	7/1/87
Qn	AC *4,961,806	10/9/90	Gerrie et al.	156	252	6/22/88
Qn	AD *4,972,470	11/20/90	Farago	380	3	8/6/87
Qn	AE *5,053,920	10/1/91	Staffiere et al.	361	383	10/9/90
Qn	AF *5,159,427	10/27/92	Ogura et al.	357	48	9/26/90
Qn	AG *5,253,156	10/12/93	Sakurai et al.	363	98	1/29/91
Qn	AH *5,313,150	5/17/94	Arakawa et al.	318	768	7/2/92
Qn	AI *5,355,301	10/11/94	Saito et al.	363	147	3/1/93
Qn	AJ *5,365,405	11/15/94	Hoenelein et al.	361	766	5/21/93
Qn	AK *5,384,691	1/24/95	Neugebauer, deceased et al.	361	794	1/8/93

FOREIGN PATENT DOCUMENTS

	Document No.	Date	Country	Class	Sub Class	Translation Yes No
AL						
A M						
A N						

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

Qn	AO	*Stock Product Catalog 501, Baldor Motors and Drives, January 1, 1997.
Qn	AP	*The Animatics SmartMotor, Animatics Corporation.
Qn	AQ	*Industrial electronics, Technology 1998 Analysis & Forecast, IEEE Spectrum, January 1998, Pg. 73-78.

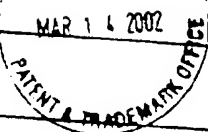
EXAMINER:

Allen Hagerola

DATE CONSIDERED:

8/05/07

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an	AR	*5,410,107	4/25/95	Schaper	174	255	3/1/93
an	AS	*5,412,558	5/2/95	Sakurai et al.	363	98	9/7/93
an	AT	*5,432,675	7/11/95	Sorimachi et al.	361	719	11/15/93
an	AU	*5,434,745	7/18/95	Shokrgozar et al.	361	735	7/26/94
an	AV	*5,452,182	9/19/95	Eichelberger et al.	361	749	4/7/92
an	AW	*5,488,542	1/30/96	Ito	361	793	8/17/94
an	AX	*5,495,394	2/27/96	Kornfeld et al.	361	764	12/19/94
an	AY	*5,532,512	7/2/96	Fillion et al.	257	686	10/3/94
an	AZ	*5,544,017	8/6/96	Beilin et al.	361	790	7/19/94
an	BA	*5,604,383	2/18/97	Matsuzaki	257	778	5/11/95
an	BB	*5,608,192	3/4/97	Moriizumi et al.	174	255	7/26/95
an	BC	*5,608,617	3/4/97	Morrison et al.	363	147	5/3/96

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Document No.	Date	Country	Class	Sub Class	Translation Yes No
BD					

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an	BE	*Craig D.T. Bratten, Peter H. Cobbold, Jonathan M. Cooper: Micromachining Sensors for Electrochemical Measurement in Subnanoliter Volumes: <i>Anal. Chem.</i> , 1997, Vol. 69 No. 2, January 15, 1997, pgs. 253-258.
an	BF	*K. Leyendecker, W. Bacher, W. Stark, A. Thommes: New Microelectrodes For the Investigation Of the Electroforming Of Liga Microstructures: <i>Electrochimica Acta</i> , 1994, Vol. 39, No. 8 9, pgs. 1139-1143.
an	BG	*Osamu Niwa, Masao Morita, Hisao Tabei: Fabrication and characteristics of vertically separated interdigitated array electrodes: <i>J. Electroanal. Chem.</i> , 1989, 267, pgs. 291-297.

EXAMINER:

Ab. Naglerola

DATE CONSIDERED:

8/03/04

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CM	BH	*5,616,888	4/1/97	McLaughlin et al.	174	260	9/29/95
CM	BI	*5,619,108	4/8/97	Komurasaki et al.	318	140	7/10/95
CM	BJ	*5,629,559	5/13/97	Miyahara	257	666	12/6/94
CM	BK	*5,629,574	5/13/97	Cognetti et al.	310	71	6/30/95
CM	BL	*5,634,267	6/3/97	Farnworth et al.	29	840	11/14/94
CM	BM	*5,641,944	6/24/97	Wieloch et al.	174	252	9/29/95
	BN						
	BO						

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BP						
BQ						
BR						

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CM	BS	*Alan M. Bond, Darryl Luscombe, Keith B. Oldham, Cynthia G. Zoski; A Comparison Of the Chronoamperometric Response At Inlaid and Recessed Disc Microelectrodes; <u>J. Electroanal. Chem.</u> , 1988, 249, pgs. 1-14.
CM	BT	*Thor D. Osborn, Paul Yager; Formation of Planar Solvent-Free Phospholipid Bilayers by Langmuir-Blodgett Transfer of Monolayers to Micromachined Apertures in Silicon; <u>Langmuir</u> , 1995, 11, pgs. 8-12.
CM	BU	*Rose A. Clark, Paula Beyer Hietpas, Andrew G. Ewing; Electrochemical Analysis in Picoliter Microvials; <u>Anal. Chem.</u> , 1997, 69, pgs. 259-263.
CM	BV	*K.C. Burgers, K.J. Olejniczak, S.S. Ang, E. Porter; The Use of Multichip Module Technology for Power Electronics Miniaturization and Packaging; Department of Electrical Engineering, University of Arkansas; High Density Electronics Center (HiDEC), University of Arkansas, <u>Abstract</u> , 1997, pgs. 35-41.

EXAMINER: *Alb. Hagerola*DATE CONSIDERED: *8/05/04*

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an	BW 5,290,420	3 1994	Matson	204	403	
an	BX 5,030,310	7 1991	Wogoman	156	252	
an	BY 5,066,372	11 1991	Weetall	205	777.5	
an	BZ 5,846,814	12 1998	Galla et al.	435	287.2	
an	CA 5,605,662	2 1997	Heller et al.	422	68.1	
an	CB 5,344,545	3 1994	Tsukada et al.	204	415	
	CC					
	CD					

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	Document No.	Date	Country	Class	Sub Class	Translation Yes No
	CE					
	CF					
	CG					

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

	CH	
	CI	
	CJ	
	CK	

EXAMINER: Alb. Neguerola DATE CONSIDERED: 8/05/04
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